







CD54ACT138, CD74ACT138 SCHS329B - JANUARY 2003 - REVISED APRIL 2024

CDx4ACT138 3-Line to 8-Line Decoders/Demultiplexers

1 Features

- Inputs are TTL-voltage compatible
- Speed of bipolar F, AS, and S, with significantly reduced power consumption
- Designed specifically for high-speed memory decoders and data-transmission systems
- Incorporate three enable inputs to simplify cascading and/or data reception
- Balanced propagation delays
- ±24mA output drive current
 - Fanout to 15 F devices
- SCR-latchup-resistant CMOS process and circuit
- Exceeds 2kV ESD protection per MIL-STD-883, method 3015

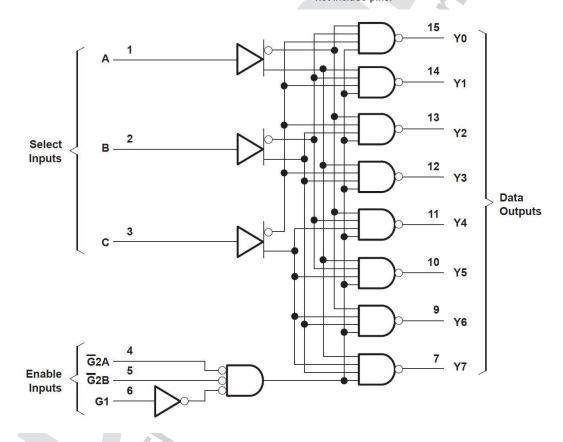
2 Description

The 'ACT138 decoders/demultiplexers are designed for high-performance memory-decoding and dataapplications that require very propagation-delay times. In high-performance memory systems, these decoders can be used to minimize the effects of system decoding.

Device Information

PART NUMBER PACKAGE ⁽¹⁾		PACKAGE SIZE(2)	BODY SIZE(3)		
CDv4ACT138	E (PDIP, 16)	19.3mm × 9.4mm	19.3mm × 6.35mm		
CDx4ACT138	M (SOIC, 16)	9.9mm × 6mm	9.9mm × 3.9mm		

- For more information, see Section 10.
- (2)The package size (length × width) is a nominal value and includes pins, where applicable.
- (3)The body size (length × width) is a nominal value and does not include pins.



ogic Diagram (Positive Logic)



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3 Pin Configuration and Functions

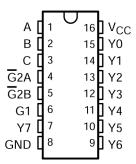


Figure 3-1. CD54ACT138 F Package, CD74ACT138 E or M Package (Top View)

Table 3-1. Pin Functions

PIN		TYPE(1)	DESCRIPTION
NAME	NO.	ITPE\''	DESCRIPTION
Α	1	I	Input A
В	2	I	Input B
С	3	I	Input C
G2A	4	I	Strobe Input 2A, active low
G2B	5	I	Strobe Input 2B, active low
G1	6	I	Strobe Input
Y7	7	0	Output 7
GND	8	G	Ground
Y6	9	0	Output 6
Y5	10	0	Output 5
Y4	11	0	Output 4
Y3	12	0	Output 3
Y2	13	0	Output 2
Y1	14	0	Output 1
Y0	15	0	Output 0
V _{CC}	16	Р	Positive Supply

(1) I = Input, O = Output, I/O = Input or Output, G = Ground, P = Power.



4 Specifications

4.1 Absolute Maximum Ratings

over operating free-air temperature range (unless otherwise noted)(1)

			MIN	MAX	UNIT
V _{CC}	Supply voltage range	Supply voltage range		6	V
I _{IK} (2)	Input clamp current	$(V_I < 0 \text{ V or } V_I > V_{CC})$		±20	mA
I _{OK} (2)	Output clamp current	$(V_O < 0 \text{ V or } V_O > V_{CC})$		±50	mA
Io	Continuous output current	$(V_O > 0 \text{ V or } V_O < V_{CC})$		±50	mA
	Continuous current through V _{CC} or GND			±100	mA
T _{stg}	Storage temperature range		-65	150	°C

⁽¹⁾ Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

4.2 ESD Ratings

			VALUE	UNIT
V _(ESD)	Electrostatic discharge	Human-body model (HBM), per ANSI/ESDA/JEDEC JS-001 ⁽¹⁾	±2000	V

⁽¹⁾ JEDEC document JEP155 states that 500-V HBM allows safe manufacturing with a standard ESD control process.

4.3 Recommended Operating Conditions

over operating free-air temperature range (unless otherwise noted)(1)

		T _A = 2	T _A = 25°C		-55°C to 125°C		-40°C to 85°C	
		MIN	MAX	MIN	MAX	MIN	MAX	UNIT
V _{CC}	Supply voltage	4.5	5.5	4.5	5.5	4.5	5.5	V
V _{IH}	High-level input voltage	2		2		2		V
V _{IL}	Low-level input voltage		0.8		0.8		0.8	V
VI	Input voltage	0	Vcc	0	V _{CC}	0	V _{CC}	V
Vo	Output voltage	0	V _{CC}	0	V _{CC}	0	V _{CC}	V
I _{OH}	High-level output current		-24		-24		-24	mA
I _{OL}	Low-level output current		24		24		24	mA
Δt/Δν	Input transition rise or fall rate		10		10		10	ns/V

⁽¹⁾ All unused inputs of the device must be held at V_{CC} or GND to ensure proper device operation. Refer to the TI application report, Implications of Slow or Floating CMOS Inputs, literature number SCBA004.

4.4 Thermal Information

THERMAL METRIC ⁽¹⁾		CD7	CD74ACT138			
		E	М	UNIT		
		16 PINS	16 PINS			
$R_{\theta JA}$	Junction-to-ambient thermal resistance	67	106.6	°C/W		

⁽¹⁾ For more information about traditional and new thermal metrics, see the Semiconductor and IC Package Thermal Metrics application report.

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⁽²⁾ The input and output voltage ratings may be exceeded if the input and output current ratings are observed.

4.5 Electrical Characteristics

over recommended operating free-air temperature range (unless otherwise noted)

DADAMETED	TEST CO	NDITIONS	\ \ \ \	TA = 25	5 °C	-55°C to	125°C	-40°C to	85°C	UNIT
PARAMETER	IESI CO	NDITIONS V _{CC}		MIN	MAX	MIN	MAX	MIN	MAX	UNII
		I _{OH} = -50 μA	4.5 V	4.4		4.4	1	4.4		
V	$V_{I} = V_{IH}$ or V_{IL}	I _{OH} = -24 mA	4.5 V	3.94		3.7		3.8		V
V _{OH}	VI - VIH OI VIL	$I_{OH} = -50 \text{ mA}^{(1)}$	5.5 V			3.85				V
		$I_{OH} = -75 \text{ mA}^{(1)}$	5.5 V					3.85		
		I _{OL} = 50 μA	4.5 V		0.1		0.1		0.1	⊣ ∣
V	$V_{I} = V_{IH} \text{ or } V_{IL}$	I _{OL} = 24 mA	4.5 V		0.36		0.5		0.44	
V _{OL}		$I_{OL} = 50 \text{ mA}^{(1)}$	5.5 V				1.65	7 0	2	
		$I_{OL} = 75 \text{ mA}^{(1)}$	5.5 V						1.65	
I _I	$V_I = V_{CC}$ or GND		5.5 V		±0.1		±1		±1	μΑ
I _{cc}	$V_I = V_{CC}$ or GND,	I _O = 0	5.5 V		8		160		80	μΑ
ΔI _{CC} (2)	V _I = V _{CC} - 2.1 V		4.5 V to 5.5 V		2.4		3		2.8	mA
C _i					10		10		10	PF

Test one output at a time, not exceeding 1-second duration. Measurement is made by forcing indicated current and measuring voltage to minimize power dissipation. Test verifies a minimum 50-Ω transmission-line drive capability at 85°C and 75-Ω transmission-line drive capability at 125°C.

(2) Additional quiescent supply current per input pin, TTL inputs high, 1 unit load

Table 4-1. Act Input Load Table

INPUT	UNIT LOAD
A, B, or C	0.83
G2A or G2B	1
G1	0.42

4.6 Switching Characteristics

over recommended operating free-air temperature range, V_{CC} = 5V ± 0.5V, C_L = 50pF (unless otherwise noted) (see Load Circuit and Voltage Waveforms)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	-55°C to	125°C	-40°C to 8	5°C	UNIT
PARAMETER	PROW (INFOT)	10 (0011 01)	MIN	MAX	MIN	MAX	ONII
t _{PLH}	A, B, C	Any Y	3	12	3.1	10.9	no
t _{PHL}		Ally 1	3	12	3.1	10.9	ns
t _{PLH}	G1	Any Y	2.8	11	2.8	10	20
t _{PHL}	G1		2.8	11	2.8	10	ns
t _{PLH}	G2A, G2B	Any V	2.6	10.5	2.7	9.5	no
t _{PHL}	GZA, GZB	Any Y	2.6	10.5	2.7	9.5	ns

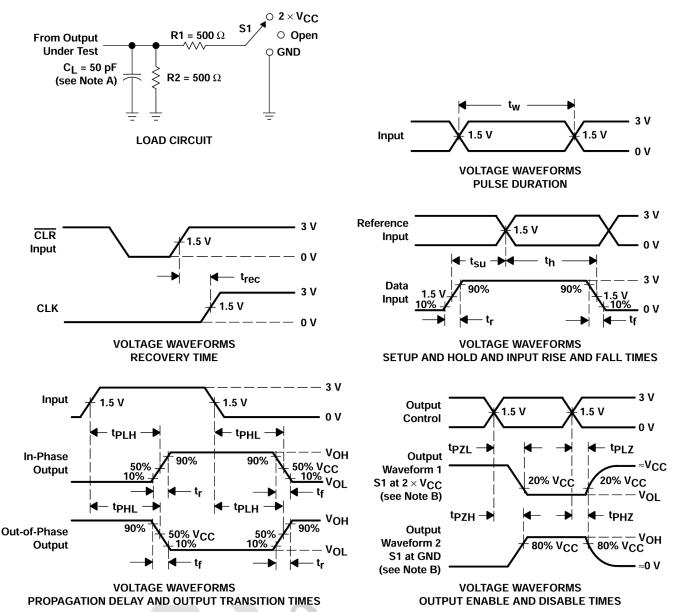
4.7 Operating Characteristics

 $V_{CC} = 5V, T_A = 25^{\circ}C$

PARAMETER			UNIT
C _{pd}	Power dissipation capacitance	110	pF



5 Parameter Measurement Information



- A. C_I includes probe and test-fixture capacitance.
- B. Waveform 1 is for an output with internal conditions such that the output is low except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high except when disabled by the output control.
- C. All input pulses are supplied by generators having the following characteristics: PRR \leq 1 MHz, Z_O = 50 Ω , t_r = 3 ns, t_f = 3 ns. Phase relationships between waveforms are arbitrary.
- D. For clock inputs, f_{max} is measured with the input duty cycle at 50%.
- E. The outputs are measured one at a time with one input transition per measurement.
- F. t_{PLH} and t_{PHL} are the same as t_{pd} .
- G. t_{PZL} and t_{PZH} are the same as t_{en} .
- H. t_{PLZ} and t_{PHZ} are the same as t_{dis} .
- I. All parameters and waveforms are not applicable to all devices.

Figure 5-1. Load Circuit and Voltage Waveforms



TEST	S1
t _{PLH} /t _{PHL}	Open
t _{PLZ} /t _{PZL}	2 × V _{CC}
t _{PHZ} /t _{PZH}	GND



6 Detailed Description

6.1 Overview

When employed with high-speed memories utilizing a fast enable circuit, the delay times of these decoders and the enable time of the memory usually are less than the typical access time of the memory. This means that the effective system delay introduced by the decoders is negligible.

The conditions at the binary-select inputs and the three enable inputs select one of eight output lines. Two active-low and one active-high enable inputs reduce the need for external gates or inverters when expanding. A 24-line decoder can be implemented without external inverters, and a 32-line decoder requires only one inverter. An enable input can be used as a data input for demultiplexing applications (see Application Information).

6.2 Functional Block Diagram

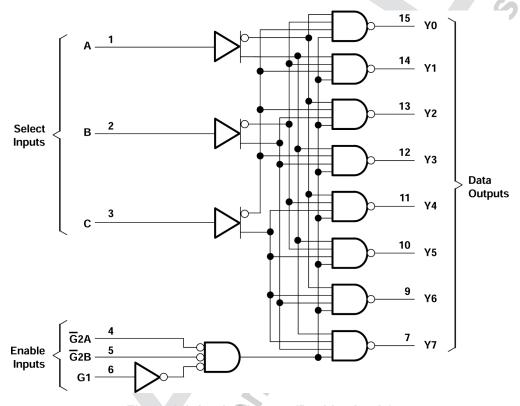


Figure 6-1. Logic Diagram (Positive Logic)

6.3 Device Functional Modes

Table 6-1. Function Table

	ENABLE IN	PUTS	8	SELECT	INPUTS	OUTPUTS							
G1	G2A	G2B	С	В	Α	Y0	Y1	Y2	Y3	Y4	Y5	Y6	Y7
Х	Н	X	Х	X	Х	Н	Н	Н	Н	Н	Н	Н	Н
X	X	Н	Х	Х	Х	Н	Н	Н	Н	Н	Н	Н	Н
L	X	X	Х	X	Х	Н	Н	Н	Н	Н	Н	Н	Н
Н	L	L	L	L	L	L	Н	Н	Н	Н	Н	Н	Н
Н	L	L	L	L	Н	Н	L	Н	Н	Н	Н	Η	Н
Н	L	L	L	Н	L	Н	Н	L	Н	Н	Н	Η	Н
Н	L	L	L	Н	Н	Н	Н	Н	L	Н	Н	Н	Н
Н	L	L	Н	L	L	Н	Н	Н	Н	L	Н	Н	Н
Н	L	L	Н	L	Н	Н	Н	Н	Н	Н	L	Η	Н

Table 6-1. Function Table (continued)

	ENABLE IN	PUTS	SELECT INPUTS			OUTPUTS							
G1	G2A	G2B	С	В	Α	Y0	Y1	Y2	Y3	Y4	Y5	Y6	Y7
Н	L	L	Н	Н	L	Н	Н	Н	Н	Н	Н	L	Н
Н	L	L	Н	Н	Н	Н	Н	Н	Н	Н	Н	Н	L



7 Application and Implementation

Note

Information in the following applications sections is not part of the TI component specification, and TI does not warrant its accuracy or completeness. TI's customers are responsible for determining suitability of components for their purposes, as well as validating and testing their design implementation to confirm system functionality.

7.1 Application Information

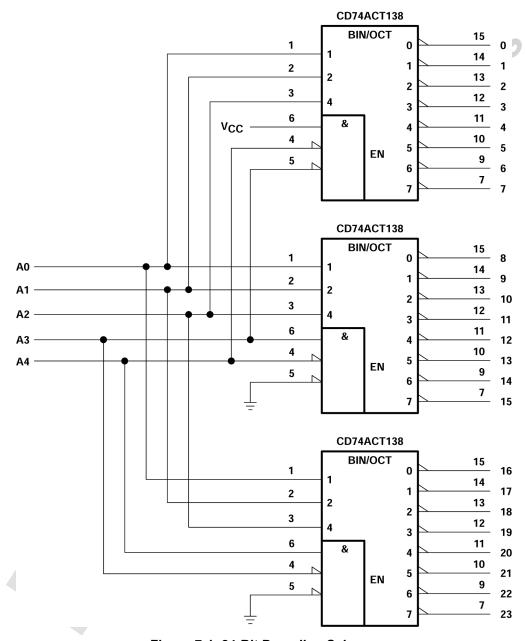


Figure 7-1. 24-Bit Decoding Scheme



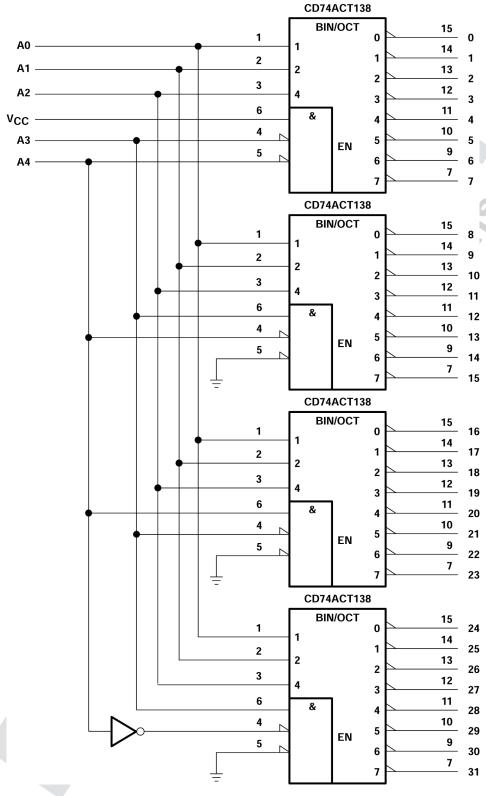


Figure 7-2. 32-Bit Decoding Scheme

7.2 Power Supply Recommendations

The power supply can be any voltage between the minimum and maximum supply voltage rating located in the *Recommended Operating Conditions*. Each V_{CC} terminal should have a good bypass capacitor to prevent power disturbance. A $0.1\mu F$ capacitor is recommended for this device. It is acceptable to parallel multiple bypass capacitors to reject different frequencies of noise. The $0.1\mu F$ and $1\mu F$ capacitors are commonly used in parallel. The bypass capacitor should be installed as close to the power terminal as possible for best results.

7.3 Layout

7.3.1 Layout Guidelines

When using multiple-input and multiple-channel logic devices, inputs must never be left floating. In many cases, functions or parts of functions of digital logic devices are unused; for example, when only two inputs of a triple-input AND gate are used or only 3 of the 4 buffer gates are used. Such unused input pins must not be left unconnected because the undefined voltages at the outside connections result in undefined operational states. All unused inputs of digital logic devices must be connected to a logic high or logic low voltage, as defined by the input voltage specifications, to prevent them from floating. The logic level that must be applied to any particular unused input depends on the function of the device. Generally, the inputs are tied to GND or V_{CC} , whichever makes more sense for the logic function or is more convenient.

7.3.2 Layout Example

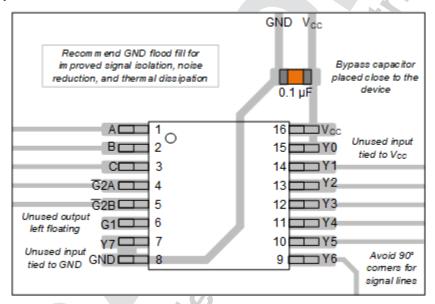


Figure 7-3. Example Layout for the CD74ACT138

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8 Device and Documentation Support

8.1 Documentation Support (Analog)

8.1.1 Related Documentation

PARTS	PRODUCT FOLDER	SAMPLE & BUY	TECHNICAL DOCUMENTS	TOOLS & SOFTWARE	SUPPORT & COMMUNITY	
CD54ACT138	Click here	Click here	Click here	Click here	Click here	
CD74ACT138	Click here	Click here	Click here	Click here	Click here	

8.2 Receiving Notification of Documentation Updates

To receive notification of documentation updates, navigate to the device product folder on ti.com. Click on *Notifications* to register and receive a weekly digest of any product information that has changed. For change details, review the revision history included in any revised document.

8.3 Support Resources

TI E2E[™] support forums are an engineer's go-to source for fast, verified answers and design help — straight from the experts. Search existing answers or ask your own question to get the quick design help you need.

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8.4 Trademarks

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8.5 Electrostatic Discharge Caution



This integrated circuit can be damaged by ESD. Texas Instruments recommends that all integrated circuits be handled with appropriate precautions. Failure to observe proper handling and installation procedures can cause damage.

ESD damage can range from subtle performance degradation to complete device failure. Precision integrated circuits may be more susceptible to damage because very small parametric changes could cause the device not to meet its published specifications.

8.6 Glossary

TI Glossary

This glossary lists and explains terms, acronyms, and definitions.

9 Revision History

Changes from Revision A (February 2003) to Revision B (April 2024)

Page

- Added Package Information table, Pin Functions table, ESD Ratings table, Thermal Information table, Device Functional Modes, Application and Implementation section, Device and Documentation Support section, and Mechanical, Packaging, and Orderable Information section
- · Updated RθJA values: M = 73 to 106.6, all values in °C/W4

10 Mechanical, Packaging, and Orderable Information

The following pages include mechanical, packaging, and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.

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PACKAGING INFORMATION

Orderable Device	Status	Package Type	Package Drawing	Pins	Package Qty	Eco Plan	Lead finish/ Ball material	MSL Peak Temp	Op Temp (°C)	Device Marking (4/5)	Samples
CD54ACT138F3A	ACTIVE	CDIP	J	16	25	Non-RoHS & Green	SNPB	N / A for Pkg Type	-55 to 125	CD54ACT138F3A	Samples
CD74ACT138E	ACTIVE	PDIP	N	16	25	RoHS & Green	NIPDAU	N / A for Pkg Type	-55 to 125	CD74ACT138E	Samples
CD74ACT138M96	ACTIVE	SOIC	D	16	2500	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-55 to 125	ACT138M	Samples
CD74ACT138M96G4	ACTIVE	SOIC	D	16	2500	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-55 to 125	ACT138M	Samples

(1) The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBSOLETE: TI has discontinued the production of the device.

(2) RoHS: TI defines "RoHS" to mean semiconductor products that are compliant with the current EU RoHS requirements for all 10 RoHS substances, including the requirement that RoHS substance do not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, "RoHS" products are suitable for use in specified lead-free processes. TI may reference these types of products as "Pb-Free".

RoHS Exempt: TI defines "RoHS Exempt" to mean products that contain lead but are compliant with EU RoHS pursuant to a specific EU RoHS exemption.

Green: TI defines "Green" to mean the content of Chlorine (CI) and Bromine (Br) based flame retardants meet JS709B low halogen requirements of <=1000ppm threshold. Antimony trioxide based flame retardants must also meet the <=1000ppm threshold requirement.

- (3) MSL, Peak Temp. The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.
- (4) There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.
- (5) Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.
- (6) Lead finish/Ball material Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

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OTHER QUALIFIED VERSIONS OF CD54ACT138, CD74ACT138:

Catalog : CD74ACT138

Military: CD54ACT138

NOTE: Qualified Version Definitions:

- Catalog TI's standard catalog product
- Military QML certified for Military and Defense Applications

PACKAGE MATERIALS INFORMATION

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TAPE AND REEL INFORMATION





A0	Dimension designed to accommodate the component width
В0	Dimension designed to accommodate the component length
K0	Dimension designed to accommodate the component thickness
W	Overall width of the carrier tape
P1	Pitch between successive cavity centers

QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



*All dimensions are nominal

Device		Package Drawing		SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
CD74ACT138M96	SOIC	D	16	2500	330.0	16.4	6.5	10.3	2.1	8.0	16.0	Q1

PACKAGE MATERIALS INFORMATION

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*All dimensions are nominal

Ì	Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
ı	CD74ACT138M96	SOIC	D	16	2500	340.5	336.1	32.0

PACKAGE MATERIALS INFORMATION

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TUBE



*All dimensions are nominal

Device	Package Name	Package Type	Pins	SPQ	L (mm)	W (mm)	T (µm)	B (mm)
CD74ACT138E	N	PDIP	16	25	506	13.97	11230	4.32
CD74ACT138E	N	PDIP	16	25	506	13.97	11230	4.32
CD74ACT138E	N	PDIP	16	25	506	13.97	11230	4.32

D (R-PDS0-G16)

PLASTIC SMALL OUTLINE



NOTES:

- A. All linear dimensions are in inches (millimeters).
- B. This drawing is subject to change without notice.
- Body length does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0.006 (0,15) each side.
- Body width does not include interlead flash. Interlead flash shall not exceed 0.017 (0,43) each side.
- E. Reference JEDEC MS-012 variation AC.



14 LEADS SHOWN



NOTES:

- A. All linear dimensions are in inches (millimeters).
- B. This drawing is subject to change without notice.
- C. This package is hermetically sealed with a ceramic lid using glass frit.
- D. Index point is provided on cap for terminal identification only on press ceramic glass frit seal only.
- E. Falls within MIL STD 1835 GDIP1-T14, GDIP1-T16, GDIP1-T18 and GDIP1-T20.

N (R-PDIP-T**)

PLASTIC DUAL-IN-LINE PACKAGE

16 PINS SHOWN



NOTES:

- A. All linear dimensions are in inches (millimeters).
- B. This drawing is subject to change without notice.
- Falls within JEDEC MS-001, except 18 and 20 pin minimum body length (Dim A).
- The 20 pin end lead shoulder width is a vendor option, either half or full width.



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